UNITED STATES DEPAR ENT OF COMMERCE PATENT AND TRADEMARK OFFICE Page 1 of 1 Serial No. Attorney Docket No. 09/608,603 0544MH-35791 LIST OF PRIOR ART CITED RECEIVED BY APPLICANT (Use several sheets if necessary) ਕ 2 6 2001 Applicant Mark Yablonski, et al. Tegnnology Center 2000 Filing Date 08 October 2000 2673 **U.S. PATENT DOCUMENTS FILING PUBLICATION** INVENTOR NAME CLASS/ **EXAMINER** DOCUMENT **SUBCLASS** DATE DATE INITIAL NO. FOREIGN PATENT DOCUMENTS TRANSLATION CLASS/ **EXAMINER** DOCUMENT **PUBLICATION** COUNTRY **SUBCLASS** YES NO DATE INITIAL NO. International PCT Search Report |PCT/US00/27817 / 10/09/2000 ВВ WO 99/27495 06/03/1999 International PCT Application G06T 11/00 BC WO 92/04678 03/19/1992 International PCT Application G06F 15/20 OTHER PRIOR ART (including author, title, date, pertinent page, etc.) Stefan Noll, Manfred G. Schendel; "Cooperative Sketching in a Network Environment for the Automotive Industry in Europe;" 1991. Mei C. Chuah, Steven F. Roth, Joe Mattis, John Kolojejchick; "SDM: Selective Dynamic Manipulation of CB Visualizations;" November 14, 1995. Jason Wood, Ken Brodlie, Helen Wright, "Visualization Over the World Wide Web and Its Application to CC Enviornmental Data;" October 27, 1996. Catherine Plaisant, Brett Milash, Anne Rose, Seth Widoff, Ben Shneiderman; "LifeLines: Visualizing Personal Histories;" April 13, 1996. Andrew W. Donoho, David L. Donoho, Miriam Gasko; "MacSpin: Dynamic Graphics on a Desktop Computer;" July 1988. Ted Mihalisin, John Timlin, John Schwegler; "Visualizing Multivariate Functions, Data, and Distributions;" May 1991. 5/22/03 Date Considered: EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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